

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Green Device Available

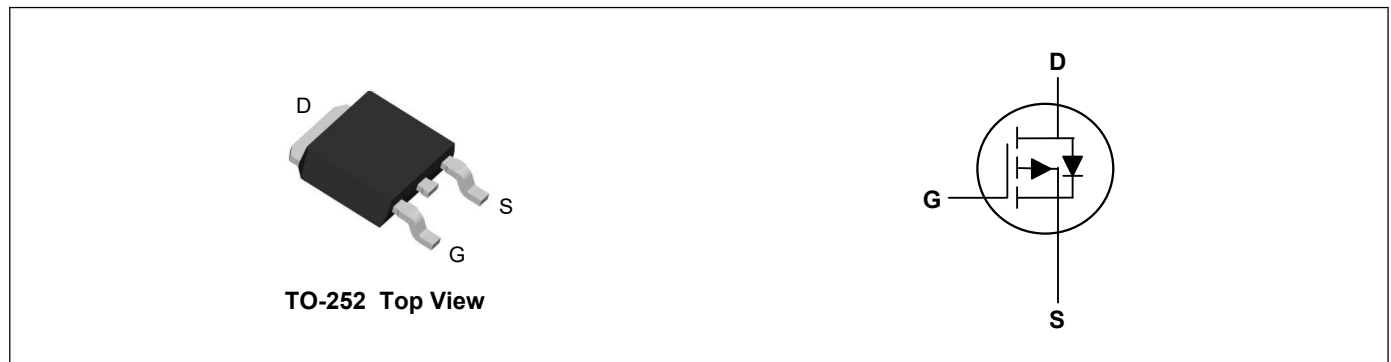
Product Summary



V_{DS}	-30	V
I_D	-35	A
$R_{DS(ON)}$ (at $V_{GS}=-10V$)	20	m Ω
$R_{DS(ON)}$ (at $V_{GS}=-4.5V$)	32	m Ω

Applications

- High Frequency Point-of-Load, Synchronous Buck Converter
- Networking DC-DC Power System
- Load Switch



Absolute Maximum Ratings ($T_C=25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Rating		Units
		10S	Steady State	
Drain-Source Voltage	V_{DS}	-30		V
Gate-Source Voltage	V_{GS}	± 20		V
Continuous Drain Current, $V_{GS} @ -10V^1$	$I_D@T_C=25^\circ\text{C}$	-35		A
Continuous Drain Current, $V_{GS} @ -10V^1$	$I_D@T_C=100^\circ\text{C}$	-22		A
Continuous Drain Current, $V_{GS} @ -10V^1$	$I_D@T_A=25^\circ\text{C}$	-13.4	-8.5	A
Continuous Drain Current, $V_{GS} @ -10V^1$	$I_D@T_A=70^\circ\text{C}$	-10.7	-6.8	A
Pulsed Drain Current ²	I_{DM}	-70		A
Single Pulse Avalanche Energy ³	EAS	72.2		mJ
Avalanche Current	I_{AS}	-38		A
Total Power Dissipation ⁴	$P_D@T_C=25^\circ\text{C}$	34.7		W
Total Power Dissipation ⁴	$P_D@T_A=25^\circ\text{C}$	5	2	W
Storage Temperature Range	T_{STG}	-55 to 150		$^\circ\text{C}$
Operating Junction Temperature Range	T_J	-55 to 150		$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	Typ	Max	Unit
Thermal Resistance Junction-Ambient ¹ ($t \leq 10s$)	$R_{\theta JA}$	---	25	$^\circ\text{C/W}$
Thermal Resistance Junction-Ambient ¹		---	62	$^\circ\text{C/W}$
Thermal Resistance Junction-Case ¹	$R_{\theta JC}$	---	3.6	$^\circ\text{C/W}$

Electrical Characteristics (T_J=25°C, unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =-250uA	-30	---	---	V
BV _{DSS} Temperature Coefficient	ΔBV _{DSS} /ΔT _J	Reference to 25°C, I _D =-1mA	---	-0.022	---	V/°C
Static Drain-Source On-Resistance ²	R _{DS(ON)}	V _{GS} =-10V, I _D =-15A	---	---	20	mΩ
		V _{GS} =-4.5V, I _D =-10A	---	---	32	mΩ
Gate Threshold Voltage	V _{GS(th)}	V _{GS} =V _{DS} , I _D =-250uA	-1.0	---	-2.5	V
V _{GS(th)} Temperature Coefficient	ΔV _{GS(th)}		---	4.6	---	mV/°C
Drain-Source Leakage Current	I _{DSS}	V _{DS} =-24V, V _{GS} =0V, T _J =25°C	---	---	-1	uA
		V _{DS} =-24V, V _{GS} =0V, T _J =55°C	---	---	-5	uA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V	---	---	±100	nA
Forward Transconductance	g _{fs}	V _{DS} =-5V, I _D =-10A	---	5	---	S
Gate Resistance	R _g	V _{DS} =0V, V _{GS} =0V, f=1MHz	---	13	---	Ω
Total Gate Charge	Q _g	V _{DS} =-15V, V _{GS} =-4.5V, I _D =-15A	---	12.5	---	nC
Gate-Source Charge	Q _{gs}		---	5.4	---	
Gate-Drain Charge	Q _{gd}		---	5	---	
Turn-On Delay Time	T _{d(on)}	V _{DD} =-15V, V _{GS} =-10V, R _G =3.3Ω, I _D =-15A	---	4.4	---	ns
Rise Time	T _r		---	11.2	---	
Turn-Off Delay Time	T _{d(off)}		---	34	---	
Fall Time	T _f		---	18	---	
Input Capacitance	C _{iss}	V _{DS} =-15V, V _{GS} =0V, f=1MHz	---	1345	---	pF
Output Capacitance	C _{oss}		---	194	---	
Reverse Transfer Capacitance	C _{rss}		---	158	---	

Drain-Source Diode Characteristics

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Continuous Source Current ^{1,5}	I _S	V _G =V _D =0V, Force Current	---	---	-35	A
Pulsed Source Current ^{2,5}	I _{SM}		---	---	-70	A
Diode Forward Voltage ²	V _{SD}	V _{GS} =0V, I _S =-1A, T _J =25°C	---	---	-1.2	V
Reverse Recovery Time	t _{rr}	I _F =-15A, di/dt=100A/μs, T _J =25°C	---	12.4	---	nS
Reverse Recovery Charge	Q _{rr}		---	5	---	nC

Note:

- The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%
- The EAS data shows Max. rating. The test condition is V_{DD}=-25V, V_{GS}=-10V, L=0.1mH
- The power dissipation is limited by 150°C junction temperature
- The data is theoretically the same as I_D and I_{DM}, in real applications, should be limited by total power dissipation.

Typical Characteristics

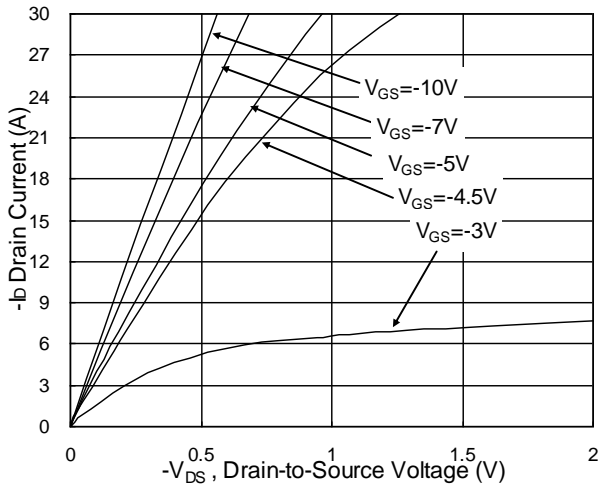


Fig.1 Typical Output Characteristics

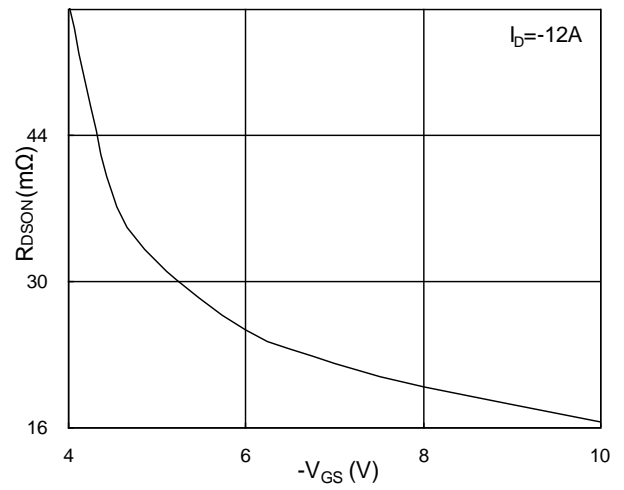


Fig.2 On-Resistance v.s Gate-Source

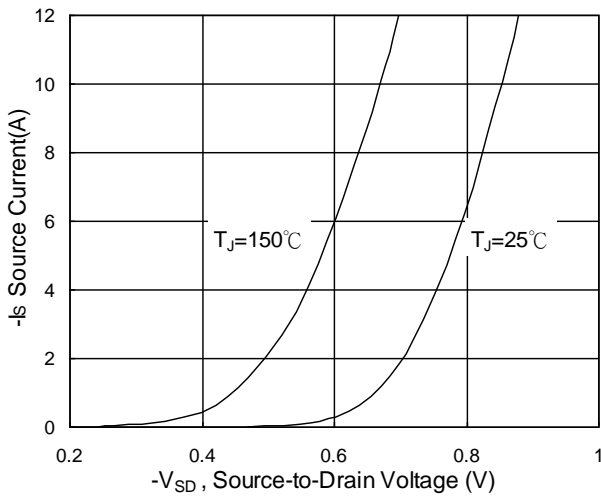


Fig.3 Forward Characteristics of Reverse

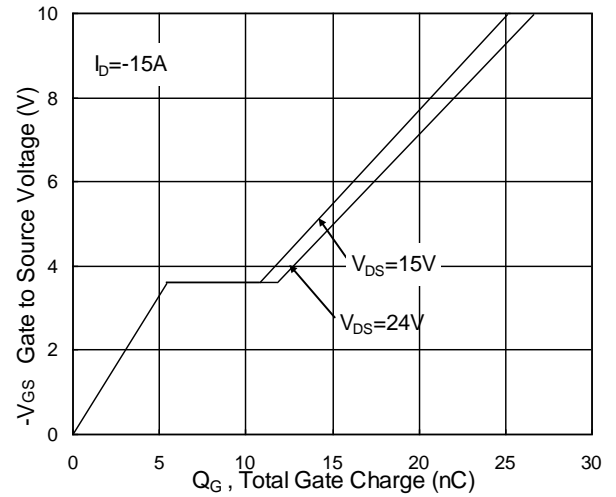


Fig.4 Gate-Charge Characteristics

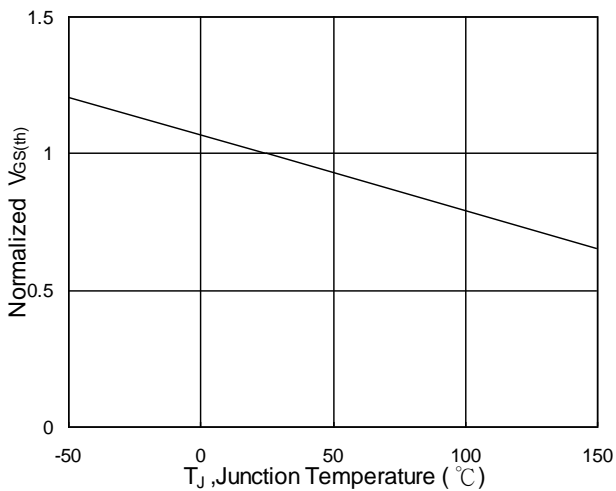


Fig.5 Normalized V_{GS(th)} v.s T_J

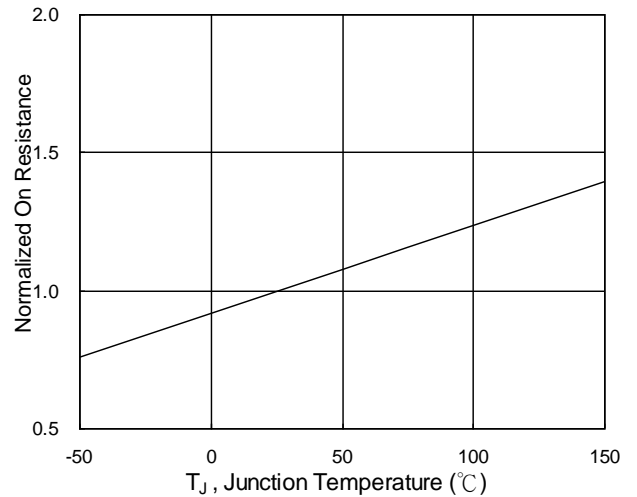


Fig.6 Normalized R_{DS(ON)} v.s T_J

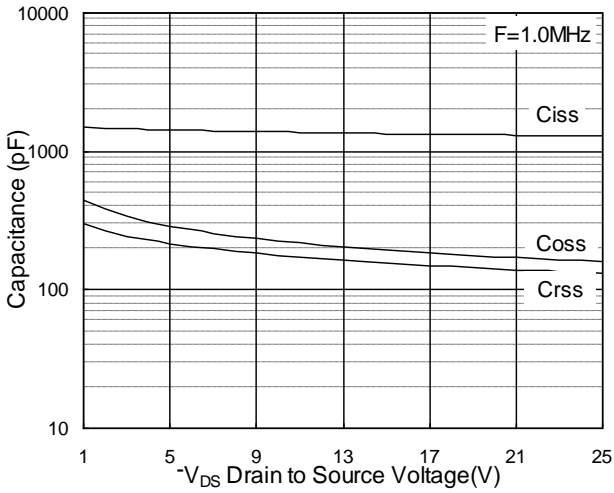


Fig.7 Capacitance

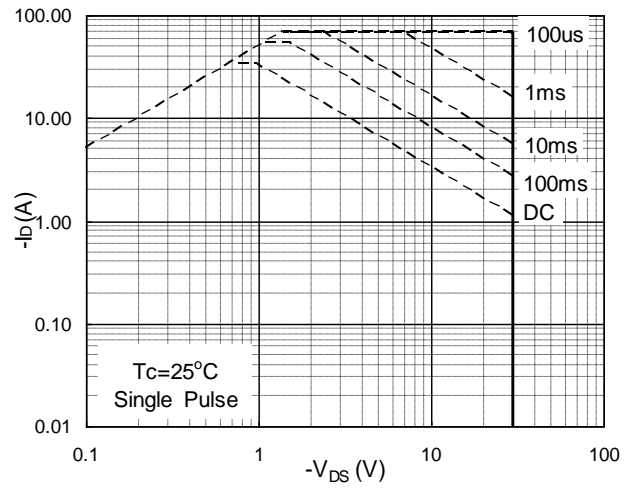


Fig.8 Safe Operating Area

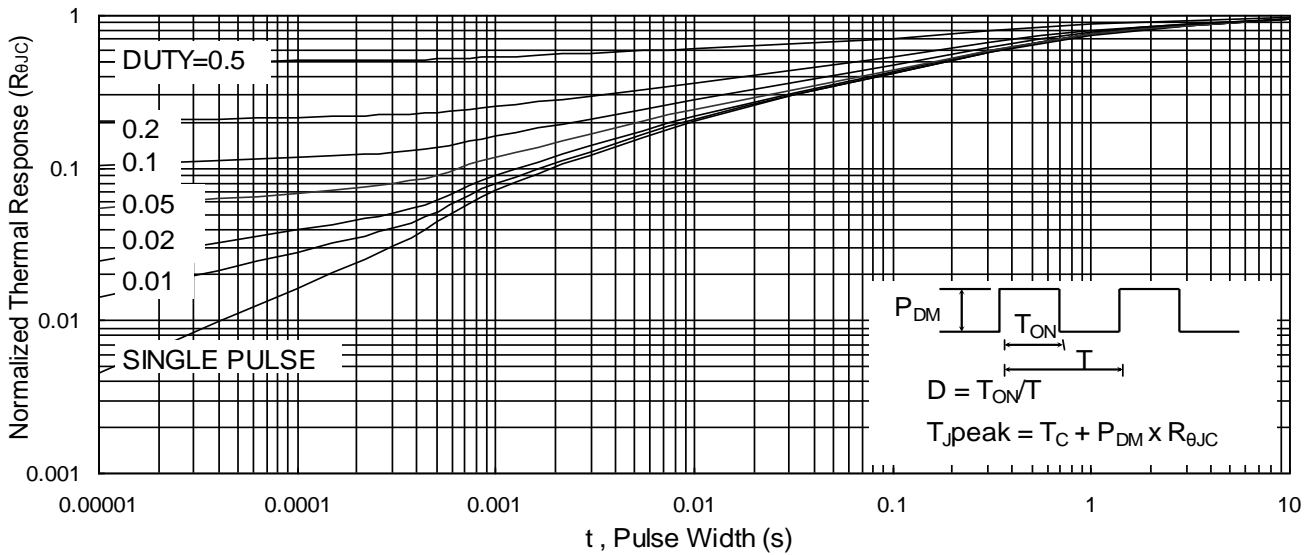


Fig.9 Normalized Maximum Transient Thermal Impedance

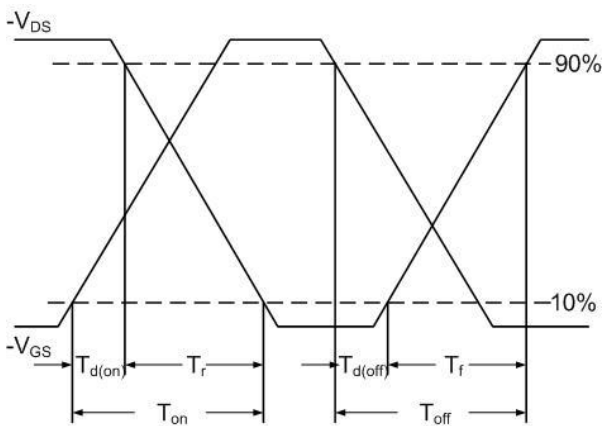


Fig.10 Switching Time Waveform

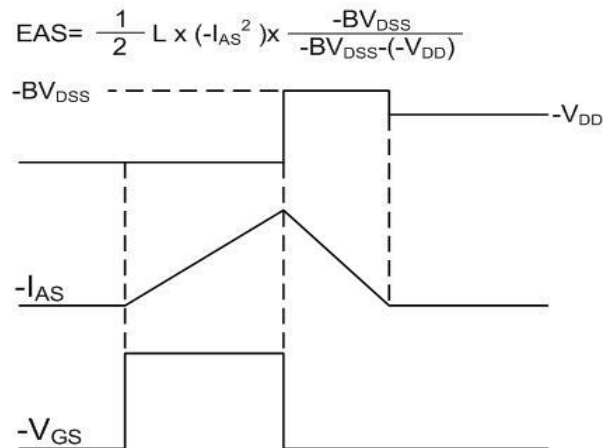
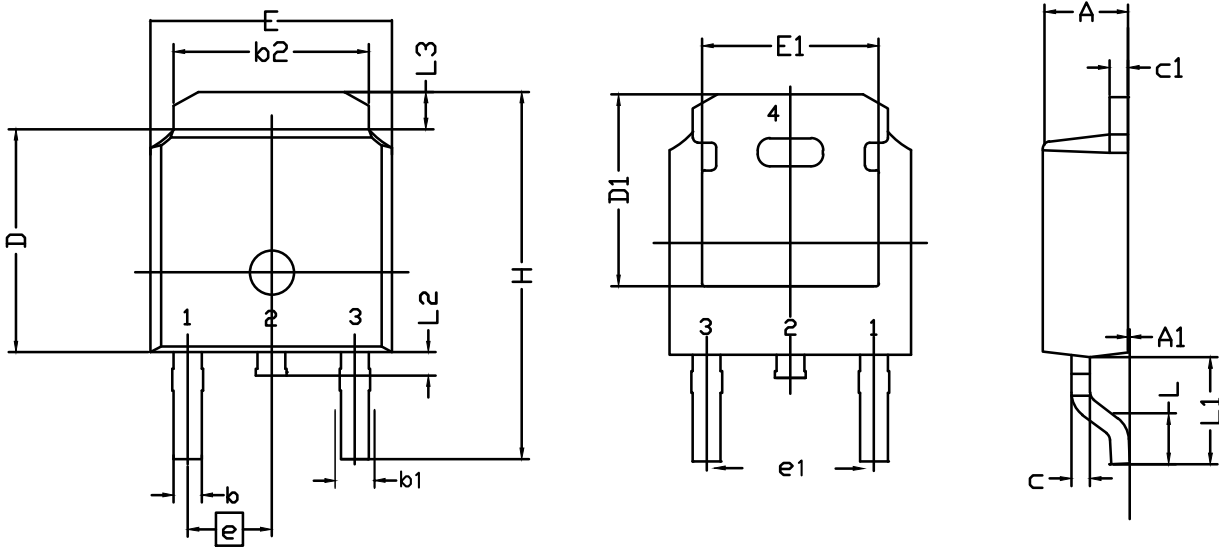


Fig.11 Unclamped Inductive Switching Waveform

TO-252 Package Outline Dimensions



Symbol	Dimensions (unit:mm)			Symbol	Dimensions (unit:mm)		
	Min	Typ	Max		Min	Typ	Max
A	2.20	2.30	2.38	E	6.40	6.60	6.731
A ₁	0.00	0.10	0.20	E ₁	4.40	--	--
b	0.64	0.76	0.89	e	2.286 BSC		
b ₁	0.77	0.85	1.14	e ₁	4.572 BSC		
b ₂	5.00	5.33	5.46	H	9.40	10.00	10.40
c	0.458	0.508	0.610	L	1.40	1.52	1.77
C ₁	0.458	0.508	0.620	L ₁	--	2.743	--
D	5.98	6.10	6.223	L ₂	0.60	0.80	1.01
D ₁	5.20	5.25	5.38	L ₃	0.90	1.06	1.25